

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09687777	PATEL, MUKESH
	Examiner Nguyen-Ba, Hoang-Vu A	Art Unit 2192

Notes	Date	Examiner
East Search -- USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	06/21/2006	HAN
717/114-118, 139-140, 148, 165 -- text search only	06/21/2006	HAN
Non Patent Literature Search -- Google Scholar	06/21/2006	HAN
Interference Search -- see search history printout	06/21/2006	HAN
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Class	SubClass	Date	Examiner
717	139	06/21/2006	HAN
717	118, 148	6/21/06	HAN
712	41	6/21/06	HAN

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